

DOCUMENT CHANGE REQUEST

510 DCR number Changes required for: General Originator: S Jeffery - ESCC Date: 2009/05/06 Date sent: 2009/05/06 Organisation: Status: IMPLEMENTED Title: Transistors MOSFET P-Channel Power, based on types 2N6849 and 2N6851 Number: 2 5206/003 Issue: Other documents affected: Page: See attachment Paragraph: See attachment Original wording: Proposed wording: Update the Maximum Ratings table (see the attachment for details) so that this detail spec is clear, complete and the content and format is in-line with other detail specifications for similar Part Types. Justification: Improve the content and clarity of the spec. Attachments: 5206003_Issue_3_-_Draft_A.pdf, null Modifications: N/A Approval signature: 12. (c f(an-9 Date signed: 2009-05-06

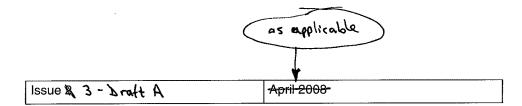


Pages 1 to 17

TRANSISTORS, POWER, MOSFET, P-CHANNEL

BASED ON TYPE 2N6849

ESCC Detail Specification No. 5206/003







ESCC Detail Specification No. 5206/003

as applicable

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DOCUMENTATION CHANGE NOTICE

(Refer to https://escies.org for ESCC DCR content)

DCR No.		CHANGE DESCRIPTION
9	3 Z6	Specification up issued to incorporate editorial and technical changes per DCR.
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7	4	
	tbd	

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Characteristics	Symbols	Maximum Ratings	Unit	Remarks
Drain-Source Voltage	V _{DS}	-100	V	Over T _{op} Note 4 , 3
Gate-Source Voltage	V _{GS}	±20	V	Over T _{op}
Drain-Gate Voltage	V_{DG}	-100	V	Over T _{op}
Drain Current	I _D	-6.5	A (1)	Continuous At T _{case} =+25°C Notes 2, 3
Source Current	I _S	-6.5	A	Continuous At T _{case} =+25°C Note 2, 1
Drain Current Pulsed	I _{DM}	-25	Α	Peak Note & 1
Power Dissipation	P _{tot}	25	W	At T _{case} ≤ +25°C •Notest
Operating Temperature Range	T _{op}	-55 to +150	°C	Note ₹4
Storage Temperature Range	T _{stg}	-55 to +150	°C	Note 5 4
Soldering Temperature	T _{sol}	+300	°C	Note & 5
Thermal Resistance, Junction-to-Case	R _{th(j-c)}	5	°C/W	

NOTES:

15 For J_{case} +25°6, derate linearily to 0W at +150°C.

1. So These ratings apply at the case. Leads are not capable of carrying maximum drain or source



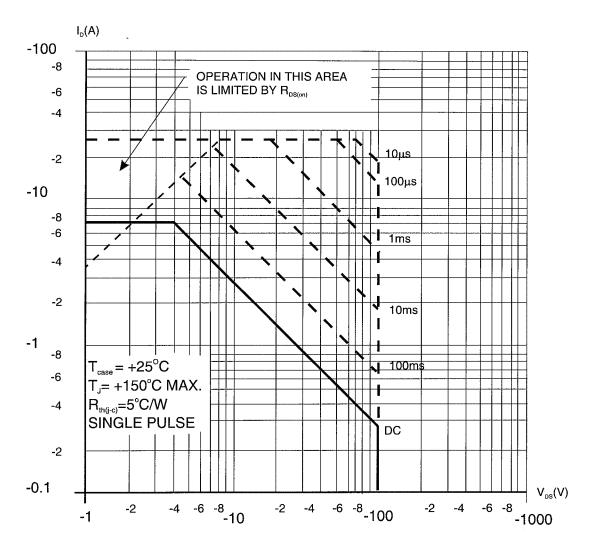
currents beyond 2mm from the case without heatsink.

2. See For $T_{case} > +25^{\circ}C$, I_{D} is derated using the following formula:

$$-I_D(A) = \sqrt{\frac{P_{rated}(W)}{0.6}}$$
, where $P_{rated}(W) = 25 - (0.2 \times (T_{case} - 25))$

3. Safe Operating Area applies as follows:

Maximum Safe Operating Area Graph



- For Variants with tin-lead plating or hot solder dip lead finish all testing performed at T_{amb} > +125°C shall be carried out in a 100% inert atmosphere.
- 5. Soluration 10 seconds maximum at a distance of not less than 1.5mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.